

# MOS FIELD EFFECT TRANSISTOR 2SK2982

# SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

## **DESCRIPTION**

The 2SK2982 is N-channel MOS Field Effect Transistor designed for high current switching applications.

### **FEATURES**

· Low on-resistance

 $R_{DS(on)1} = 12.5 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 10 \text{ V, I}_D = 15 \text{ A)}$ 

 $R_{DS(on)2} = 16.5 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.5 \text{ V, Ip} = 15 \text{ A)}$ 

 $R_{DS(on)3} = 19.0 \text{ m}\Omega \text{ MAX.} (V_{GS} = 4.0 \text{ V}, I_{D} = 15 \text{ A})$ 

- Low Ciss : Ciss = 2290 pF TYP.
- Built-in gate protection diode

## **ORDERING INFORMATION**

PART NUMBER	PACKAGE	
2SK2982	TO-251	
2SK2982-Z	TO-252	

# ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	30	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	Vgss	±20	V
Drain Current (DC)	I <sub>D(DC)</sub>	±30	Α
Drain Current (Pulse) Note	ID(pulse)	±120	Α
Total Power Dissipation (T <sub>A</sub> = 25°C)	Рт	1.0	W
Total Power Dissipation (Tc = 25°C)	Рт	30	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to + 150	°C

**Note** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1%

(TO-251)



(TO-252)



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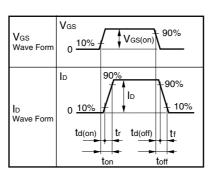


# **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

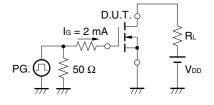
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		9.8	12.5	mΩ
	RDS(on)2	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 15 A		13.2	16.5	mΩ
	RDS(on)3	V <sub>GS</sub> = 4.0 V, I <sub>D</sub> = 15 A		15.0	19.0	mΩ
Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.0	1.5	2.0	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 15 A	13	27		S
Drain Leakage Current	IDSS	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			10	μΑ
Gate to Source Leakage Current	Igss	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±10	μΑ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		2290		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		940		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		440		pF
Turn-on Delay Time	T <sub>d(on)</sub>	I <sub>D</sub> = 15 A		40		ns
Rise Time	tr	V <sub>GS(on)</sub> = 10 V		427		ns
Turn-off Delay Time	t <sub>d(off)</sub>	V <sub>DD</sub> = 15 V		174		ns
Fall Time	Tf	R <sub>G</sub> = 10 Ω		226		ns
Total Gate Charge	Q <sub>G</sub>	I <sub>D</sub> = 30 A		53		nC
Gate to Source Charge	Qgs	V <sub>DD</sub> = 24 V		6.3		nC
Gate to Drain Charge	Q <sub>GD</sub>	V <sub>GS</sub> = 10 V		16		nC
Body Diode forward Voltage	V <sub>F(S-D)</sub>	I <sub>F</sub> = 30 A, V <sub>GS</sub> = 0 V		0.8		V
Reverse Recovery Time	Trr	I <sub>F</sub> = 30A, V <sub>GS</sub> = 0 V		49		ns
Reverse Recovery Charge	Qrr	di/dt = 100A/ <i>μ</i> s		50		nC

# **TEST CIRCUIT 1 SWITCHING TIME**

# D.U.T. PG. RG $\tau = 1 \mu s$ Duty Cycle $\leq 1\%$

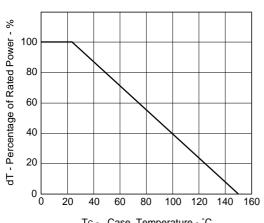


# **TEST CIRCUIT 2 GATE CHARGE**



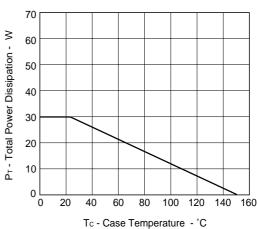
# TYPICAL CHARACTERISTICS (TA = 25°C)

# DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA

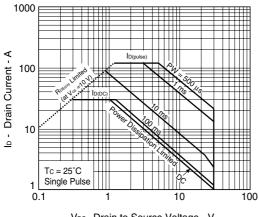


# Tc - Case Temperature - °C

# TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

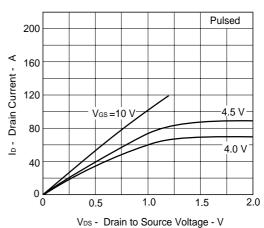




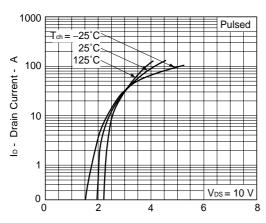


VDS - Drain to Source Voltage - V

# DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

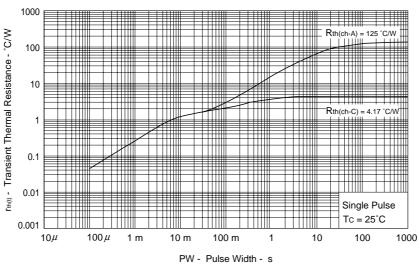


FORWARD TRANSFER CHARACTERISTICS

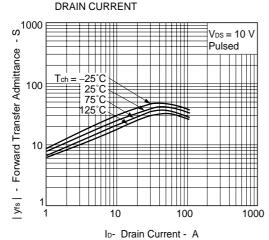


V<sub>GS</sub> - Gate to Source Voltage - V

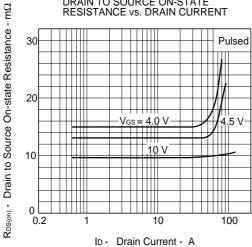
### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



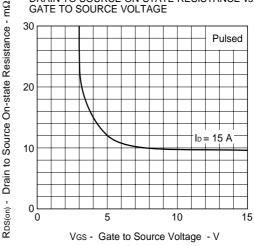
FORWARD TRANSFER ADMITTANCE vs.



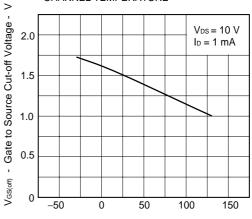
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

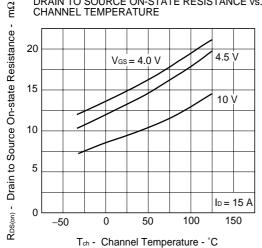


GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

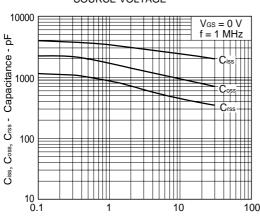


Tch - Channel Temperature - °C

# DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

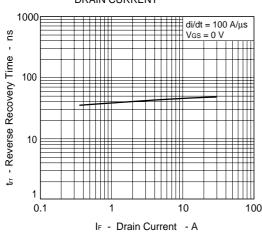


# CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

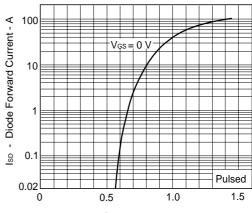


# REVERSE RECOVERY TIME vs. DRAIN CURRENT

VDS - Drain to Source Voltage - V

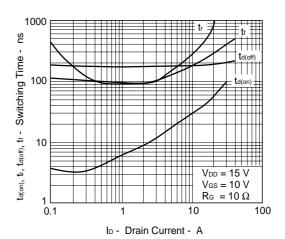


### SOURCE TO DRAIN DIODE FORWARD VOLTAGE

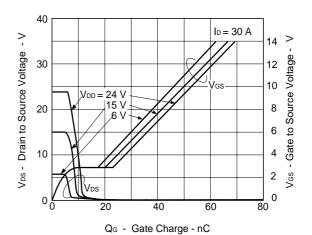


Vsp - Source to Drain Voltage - V

### SWITCHING CHARACTERISTICS



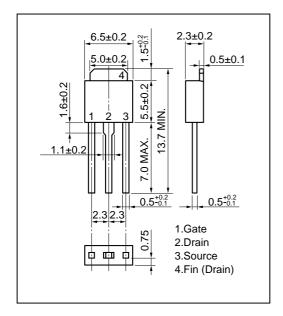
## DYNAMIC INPUT/OUTPUT CHARACTERISTICS



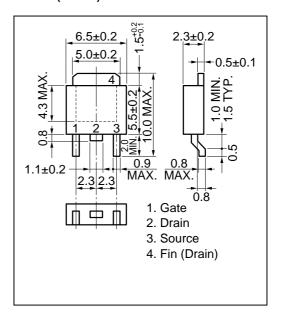


# **PACKAGE DRAWINGS (Unit: mm)**

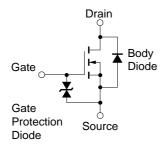
# TO-251(MP-3)



TO-252(MP-3Z)



# **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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